

KA75XXX

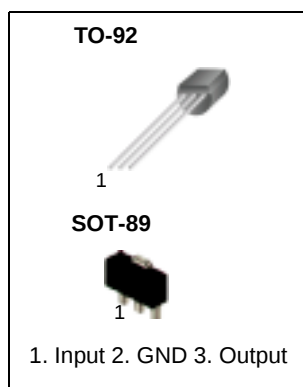
Voltage Detector

Features

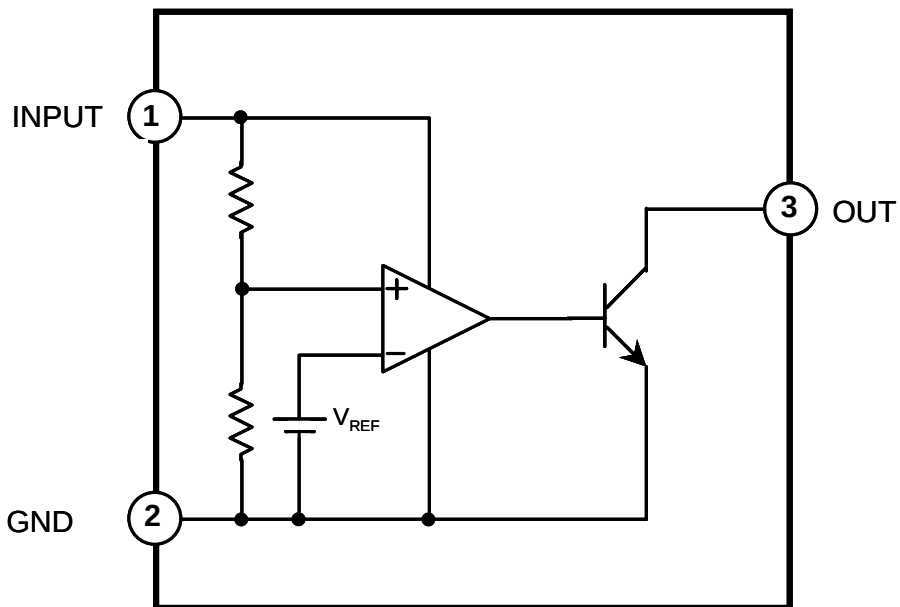
- Detecting Against Error Operations At The Power On/off.
- Resetting Function For The Low Voltage Microprocessor.
- Checking Low Battery

Description

The KA75250/KA75270/KA75290/KA75310/KA75330/KA75360/KA75390/KA75420/KA75450 prevents the error of system from supply voltage below normal voltage level at the time the power on and instantaneous power off in systems.



Internal Block Diagram

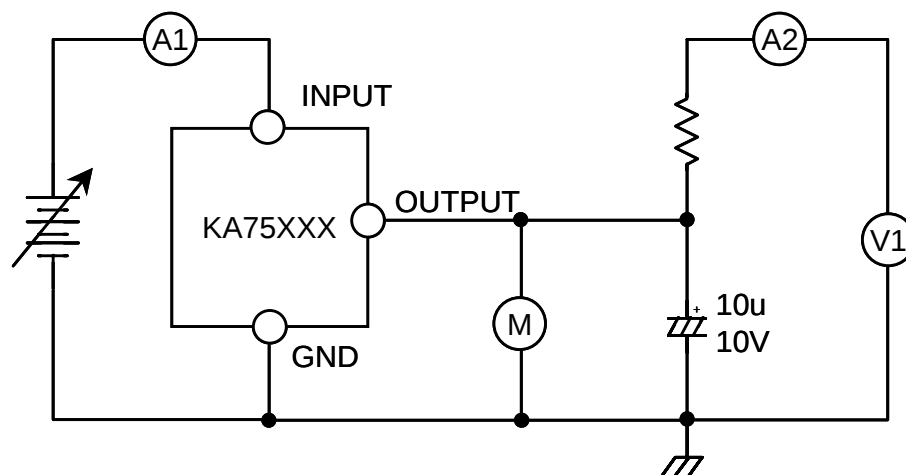
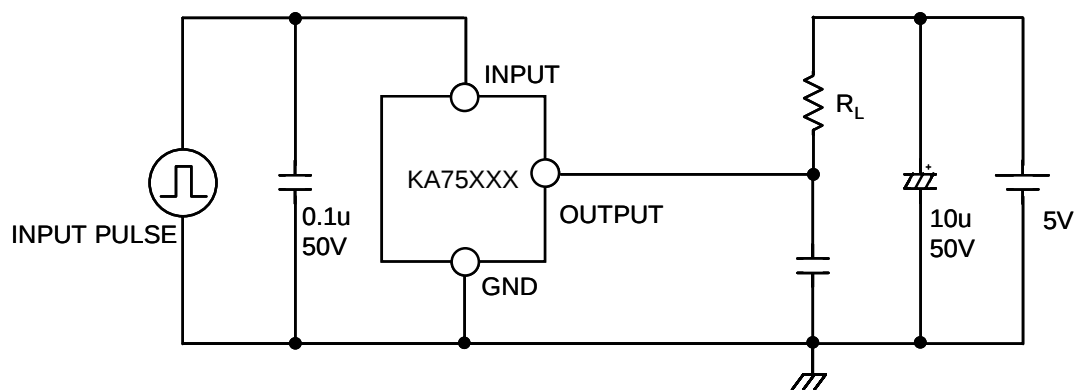
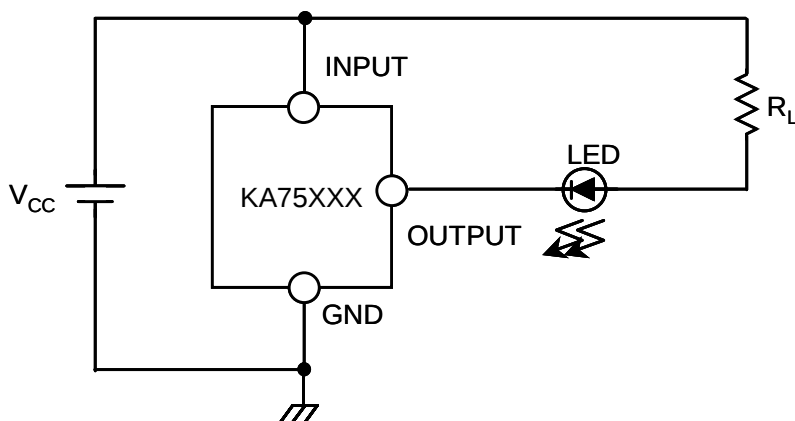


Absolute Maximum Rating (TA=25°C)

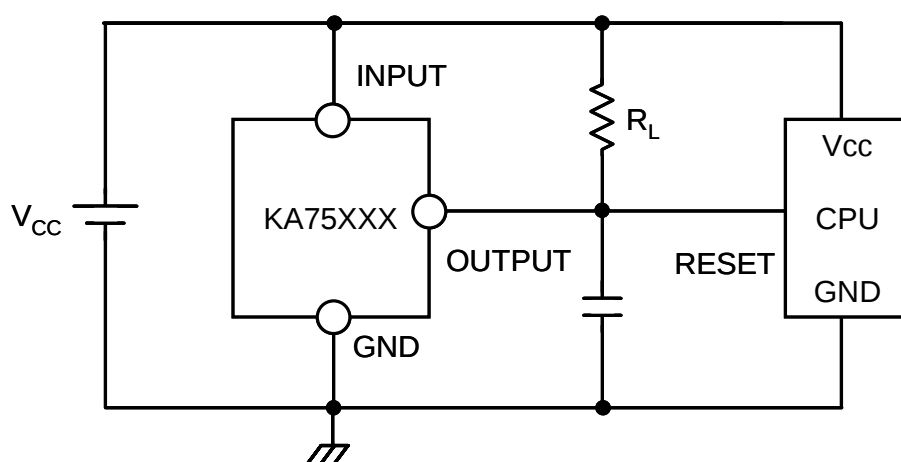
Characteristic	Symbol	Value	Unit
Supply Voltage	V _{CC}	0.3 ~ +15.0	V
Detecting Voltage	V _{DET}	2.5/2.7/2.9/3.1 3.3/3.6/3.9/4.2/4.5	V
Hysteresis Voltage	V _{HYS}	50	mV
Operating Temperature	T _{OPR}	-25 ~ +85	°C
Storage Temperature	T _{STG}	-50 ~ +150	°C
Power Dissipation TO-92 SOT-89	P _D	200 500	mW
Detecting Voltage Temperature Coefficient	$\Delta V_{DET}/\Delta T$	R _L = 200Ω, +0.01	%/°C

Electrical Characteristics (TA=25°C)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Detecting Voltage	V _{DET}	R _L = 200Ω V _{OL} ≤ 0.4V KA75250 KA75270 KA75290 KA75310 KA75330 KA75360 KA75390 KA75420 KA75450	2.35 2.55 2.75 2.95 3.15 3.45 3.75 4.05 4.35	2.5 2.7 2.9 3.1 3.3 3.6 3.9 4.2 4.5	2.65 2.85 3.05 3.25 3.45 3.75 4.05 4.35 4.65	V
Low Output Voltage	V _{OL}	R _L = 200Ω	-	-	0.4	V
Output Leakage Current	I _{LKG}	V _{CC} = 15V	-	-	0.1	μA
Hysteresis Voltage	V _{HYS}	R _L = 200Ω	30	50	100	mV
Detecting Voltage Temperature Coefficient	$\Delta V_{DET}/\Delta T$	R _L = 200Ω	-	±0.01	-	%/°C
Circuit Current(At On Time)	I _{CCL}	V _{CC} = V _{DET} (MIN) - 0.05V	-	300	500	μA
Circuit Current(At Off Time)	I _{CCH}	V _{CC} = 5.25V	-	30	50	μA
Threshold Operating Voltage	V _{TH(OPR)}	R _L = 200Ω, V _{OL} ≤ 0.4V	-	0.8	1.0	V
" L"± Transmission Delay Time	T _{OL}	R _L = 1.0kΩ, C _L = 100pF	0.6	10	-	μs
" H"± Transmission Delay Time	T _{OH}	R _L = 1.0kΩ, C _L = 100pF	-	15	20	μs
Output Current (At On Time)	I _{OLI}	V _{CC} = V _{DET} (MIN) - 0.05V, T _A = 25°C	10	20	30	mA
Output Current (At On Time)	I _{OLII}	V _{CC} = V _{DET} (MIN) - 0.05V T _A = -25 ~ +85°C	8	16	30	mA

Test Circuit 1.**Test Circuit 2.****Test Circuit 3.**

Application Circuit

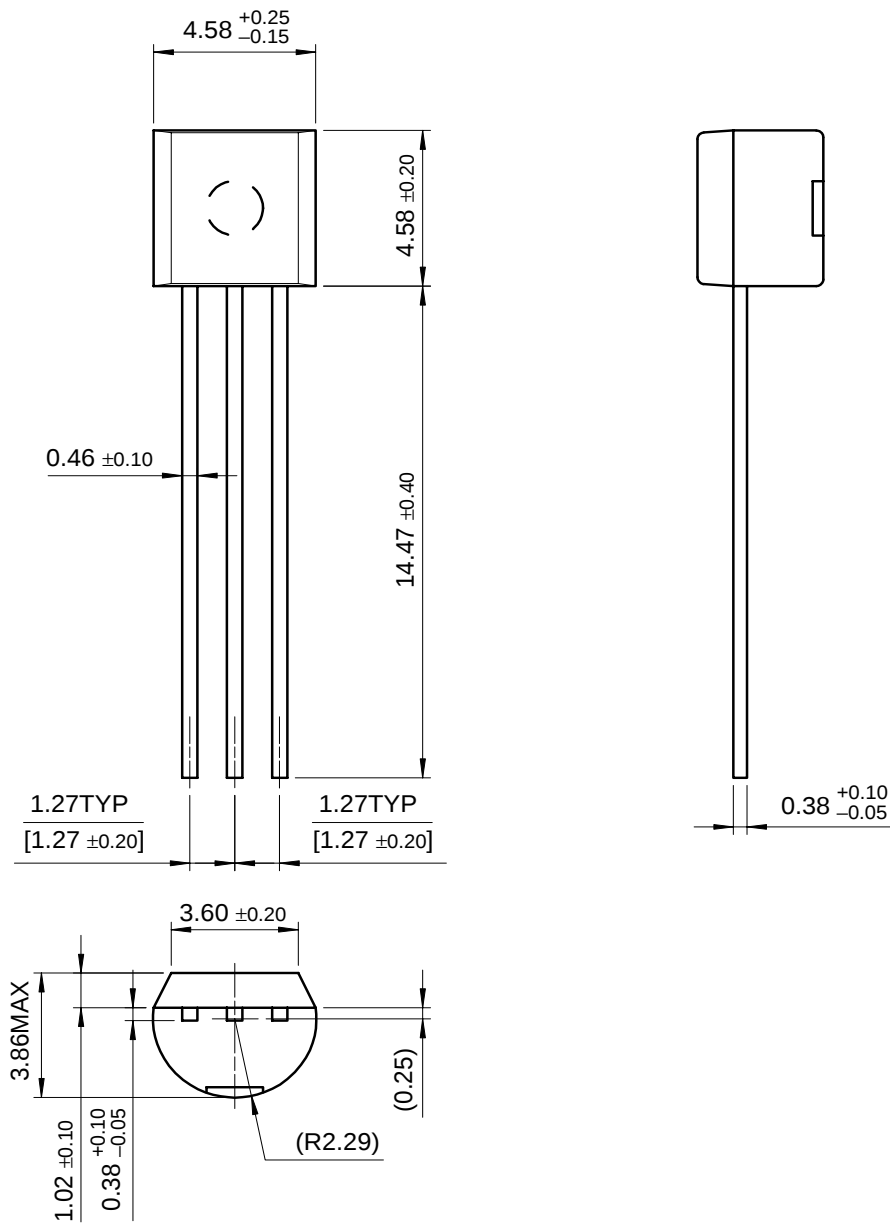


Mechanical Dimensions

Package

Dimensions in millimeters

TO-92

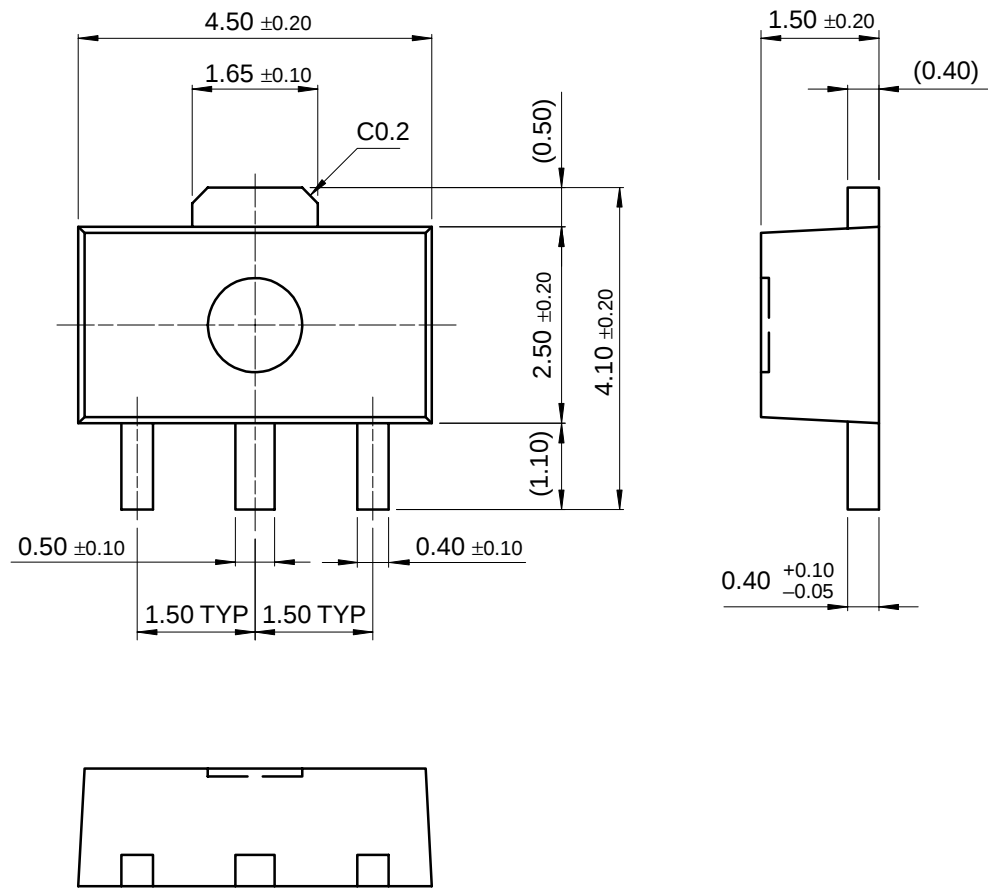


Mechanical Dimensions (Continued)

Package

Dimensions in millimeters

SOT-89



Ordering Information

Product Number	Package	Operating Temperature
KA75250Z	TO-92	-25 ~ +85°C
KA75270Z		
KA75290Z		
KA75310Z		
KA75330Z		
KA75360Z		
KA75390Z		
KA75420Z		
KA75450Z		
KA75250M	SOT-89	
KA75270M		
KA75310M		
KA75330M		
KA75360M		
KA75390M		
KA75420M		
KA75450M		

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